SHIGA7.051APC PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant

Takeshita et al.

Appl. No.

10/580,768

Filed

: May 25, 2006

For

POSITIVE RESIST

COMPOSITION AND METHOD

FOR FORMING RESIST

PATTERN

Examiner

: Eoff, A.

Group Art Unit

1795

AMENDMENT AND RESPONSE TO RESTRICTION REQUIREMENT

Mail Stop Amendment

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In response to the Restriction Requirement mailed March 19, 2008, please consider the following amendments and remarks.

Amendments to the claims are reflected in the listing of claims which begin on page 2 of this paper.

Remarks/Response to restriction requirement begin on page 9 of this paper.